

<b>Notice of References Cited</b>	Application/Control No. 10/593,205	Applicant(s)/Patent Under Reexamination HATTORI ET AL.	
	Examiner Derek J. Rosenau	Art Unit 2834	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,064,473	06-2006	Ishibashi et al.	310/330
*	B	US-2006/0169954	08-2006	Smela et al.	252/500
*	C	US-6,860,982	03-2005	Okura et al.	205/333
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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